


<b>Search Notes</b>  	<b>Application/Control No.</b>  10597110	<b>Applicant(s)/Patent Under Reexamination</b>  SCHOEN, DIERK
	<b>Examiner</b>  DAVID P ANGWIN	<b>Art Unit</b>  3729

SEARCHED			
Class	Subclass	Date	Examiner
29	592.1, 595, 622, and 832-34	5/19/08	DPA
250	221 and 222.1	7/1/10	DPA

SEARCH NOTES		
Search Notes	Date	Examiner
obtained search from Primary Examiner Minh Trinh (Class 29)	3/4/08	DPA
obtained search from Primary Examiner John Lee (Class 250)	2/8/10	DPA
obtained search from Primary Examiner Max Noori (Class 73)	2/11/10	DPA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
all listed above	all listed above	dates listed above	DPA

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